

<b>Notice of References Cited</b>	Application/Control No. 10/636,022	Applicant(s)/Patent Under Reexamination LEE ET AL.	
	Examiner Hoang V Nguyen	Art Unit 2821	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2004/0090374 A1	05-2004	Kuo Dai et al.	343/700.0MS
	B	US-6,781,546 B2	08-2004	Wang et al.	343/700MS
	C	US-6,812,892 B2	11-2004	Tai et al.	343/700MS
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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